Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/694,774	HIRANO, YUJI	
Examiner	Art Unit	
JYOTHSNA A VENKAT Ph	1615	

SEARCHED							
Class	Subclass	Date	Examiner				
_							
	-						
	,						
	· · · · · ·						
	*						
			<u> </u>				

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	PATE	EXMR		
abated hist Coperans	Ho	dy		
The search	*	X		
		·		
	·			
		·		